Notice of References Cited Application/Control No. O9/802,978 Examiner Blane J Jackson Applicant(s)/Patent Under Reexamination JEON ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,349,224	02-2002	Lim, Byung Keun	455/466
	В	US-6,487,406	11-2002	Chang et al.	455/422.1
	С	US-6,219,547	04-2001	Qaddoura et al.	455/432.1
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Application/Control No. 09/802,978 Examiner Blane J Jackson Applicant(s)/Patent Under Reexamination JEON ET AL. Art Unit Page 1 of 1

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